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Key indicators

Single-crystal X-ray study T = 295 KMean $\sigma(\text{C}-\text{C}) = 0.003 \text{ Å}$ R factor = 0.037 wR factor = 0.119 Data-to-parameter ratio = 18.4

For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e. The title compound, $C_{10}H_{13}N_3S$, was prepared by the reaction of acetone with hydrazine and phenyl isothiocyanate. The molecular structure and crystal packing are stabilized by $N-H\cdots N$ and $N-H\cdots S$ hydrogen bonds.

4-Phenyl-1-(propan-2-ylidene)thiosemicarbazide

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Comment

There is considerable current interest in the coordination chemistry of transition metals with the Schiff base family of ligands (Kovacic, 1967). In most cases, it was found that chelation of the bases with salts of transition metals occurred readily, whereas those Schiff bases which are prepared from *ortho*-hydroxy-substituted aldehydes readily form chelates similar to the type obtained from 8-hydroxyquinoline and its derivatives. In our study of these ligands, we synthesized the title compound, (I), and present its structure (Fig. 1).



The relatively short S1–C7 bond length (Table 1) indicates its double-bond character. Atoms S1/C7/N1/N2/N3 and C10/ C9/C8/N2/N3 define the mean planes p1 and p2, respectively; the dihedral angle between them is 13.6 (1)°. The dihedral angles formed by the plane of the phenyl ring with p1 and p2are 38.3 (2) and 39.6 (2)°, respectively. The molecular structure of (I) and the crystal packing are stabilized by intramolecular N–H···N and intermolecular N–H···S hydrogen



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Figure 1 View of (I), showing 30% probability displacement ellipsoids and the atom-numbering scheme.

bonds (Table 2). The relatively short distance of 3.733 (2) Å between atom C9 and the centroid (*Cg*) of the phenyl ring at (1 + x, y, z) may indicate the presence of a C-H··· π interaction (H9C···Cg = 2.79 Å and C9-H9C···Cg = 166°).

Experimental

The title compound was prepared by the reaction of acetone (0.02 mol) with hydrazine (0.02 mol) and phenyl isothiocyanate (0.02 mol). Single crystals of the title compound suitable for X-ray measurements were obtained by recrystallization from dimethyl sulfoxide solution at room temperature.

Crystal data

 $\begin{array}{l} C_{10}H_{13}N_{3}S\\ M_{r}=207.29\\ Monoclinic, P2_{1}/c\\ a=9.0660\ (18)\ \text{\AA}\\ b=10.283\ (2)\ \text{\AA}\\ c=11.889\ (2)\ \text{\AA}\\ \beta=99.07\ (3)^{\circ}\\ V=1094.5\ (4)\ \text{\AA}^{3}\\ Z=4 \end{array}$

Data collection

Enraf-Nonius CAD-4 diffractometer ω scans Absorption correction: none 3104 measured reflections 2352 independent reflections 1937 reflections with $I > 2\sigma(I)$ $R_{\text{int}} = 0.021$

Refinement

Refinement on F^2 $R[F^2 > 2\sigma(F^2)] = 0.037$ $wR(F^2) = 0.119$ S = 1.042352 reflections 128 parameters H-atom parameters constrained $D_x = 1.258 \text{ Mg m}^{-3}$ Mo K α radiation Cell parameters from 25 reflections $\theta = 4-14^{\circ}$ $\mu = 0.26 \text{ mm}^{-1}$ T = 295 (2) K Block, yellow $0.35 \times 0.25 \times 0.20 \text{ mm}$

 $\begin{aligned} \theta_{\max} &= 27.0^{\circ} \\ h &= -1 \rightarrow 10 \\ k &= -1 \rightarrow 12 \\ l &= -14 \rightarrow 14 \\ 3 \text{ standard reflections} \\ \text{every 100 reflections} \\ \text{intensity decay: none} \end{aligned}$

| $w = 1/[\sigma^2(F_o^2) + (0.06)]$ | $(42P)^2$ |
|------------------------------------------------------------|----------------|
| + 0.3495P] | |
| where $P = (F_o^2 + 2)^2$ | $F_{c}^{2})/3$ |
| $(\Delta/\sigma)_{\rm max} < 0.001$ | |
| $\Delta \rho_{\rm max} = 0.28 \ {\rm e} \ {\rm \AA}^{-3}$ | |
| $\Delta \rho_{\rm min} = -0.26 \text{ e } \text{\AA}^{-3}$ | |
| Extinction correction | SHELXL97 |
| Extinction coefficient | : 0.035 (4) |
| | |

Table 1

Selected bond lengths (Å).

| S1-C7 | 1.6816 (18) | N2-C7 | 1.359 (2) |
|-------|-------------|-------|-----------|
| N1-C7 | 1.337 (2) | N2-N3 | 1.385 (2) |
| N1-C6 | 1.420 (2) | N3-C8 | 1.279 (2) |

| Table 2 | |
|-----------------------------------|--|
| Hydrogen-bonding geometry (Å, °). | |

| $D - H \cdots A$ | D-H | $H \cdots A$ | $D \cdots A$ | $D - \mathbf{H} \cdot \cdot \cdot A$ |
|-----------------------------------------------|--------------|--------------|--------------------------|--------------------------------------|
| $N1 - H1B \cdots N3$ $N2 - H2A \cdots S1^{i}$ | 0.86 0.86 | 2.13 2.68 | 2.571 (2) 3.4713 (16) | 111 154 |
| | | | | |

Symmetry code: (i) -x, -y, -z.

H atoms were positioned geometrically and allowed to ride on their attached atoms, with N–H and C–H distances of 0.86 and 0.93–0.96 Å, respectively, and with $U_{\rm iso}(\rm H) = 1.2$ or $1.5U_{\rm eq}$ of the parent atom.

Data collection: *CAD-4 Software* (Enraf–Nonius, 1989); cell refinement: *CAD-4 Software*; data reduction: *NRCVAX* (Gabe *et al.*, 1989); program(s) used to solve structure: *SHELXS97* (Sheldrick, 1997); program(s) used to refine structure: *SHELXL97* (Sheldrick, 1997); molecular graphics: *SHELXTL/PC* (Sheldrick, 1990); software used to prepare material for publication: *WinGX* (Farrugia, 1999).

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